

Notice of References Cited	Application/Control No. 10/530,402		Applicant(s)/Patent Under Reexamination EYTAN ET AL.	
	Examiner THOMAS D. ALUNKAL		Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,129,006	10-2006	Hesselink et al.	430/1
*	B	US-6,366,542	04-2002	Kojima et al.	369/44.23
*	C	US-6,091,549	07-2000	McDonald et al.	359/637
*	D	US-6,064,529	05-2000	McDonald et al.	359/637
*	E	US-2002/0060959	05-2002	Shiono et al.	369/44.24
*	F	US-5,303,221	04-1994	Maeda et al.	369/112.1
*	G	US-2003/0067861	04-2003	Kimura, Tohru	369/112.26
*	H	US-6,291,132	09-2001	Glushko et al.	430/270.15
*	I	US-6,721,259	04-2004	Yamamoto et al.	369/112.26
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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